



PATENT

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William R. Allen

William R. Allen, Reg. No. 48,389

6 November 2003

Date

Applicants: Abdul Wahid Khan et al.
Serial No.: 10/629,053
Filed: July 29, 2003
Examiner: Unknown
Group Art Unit: 1743
Confirmation No.: 5911
For: METHOD OF MAKING A MULTI-WELL TEST PLATE HAVING
ADHESIVELY SECURED TRANSPARENT BOTTOM PANEL
Atty. Docket No.: NAC-96DV

Cincinnati, Ohio 45202

November 6, 2003

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

INFORMATION DISCLOSURE STATEMENT

In accordance with the duty of candor and good faith imposed by 37 C.F.R. §1.56 and means of complying therewith according to 37 C.F.R. §§1.97 and 1.98, the references listed on the attached Form PTO-1449 are called to the attention of the Examiner in connection with the above-identified patent application. Copies of the certain of the cited references have already been supplied in connection with U.S.

Patent Application Ser. No. 09/427,235 (now abandoned). The present application is a divisional of Serial No. 09/427,235 and claims the benefit thereof under 35 U.S.C. § 120. Therefore, under 37 C.F.R. § 1.98(d) copies of the cited references need not be provided herewith. If additional copies of these references are desired, please contact the undersigned and they will be forwarded immediately.

The Examiner is urged to consider all of the cited documents and to make an independent evaluation of the teachings and materiality of each.

Applicants do not believe that any fees are due in connection with this submission. However, if such petition is due or any fees are necessary, the Commissioner may consider this to be a request for such and charge any necessary fees to deposit account 23-3000.

Respectfully submitted,

WOOD, HERRON & EVANS, L.L.P.



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SUBSTITUTE FORM PTO-1449
(MODIFIED)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
NAC/96DVSERIAL NO.
10/629,053

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INFORMATION DISCLOSURE
STATEMENT BY APPLICANTAPPLICANT
Abdul Wahid Khan et al.FILING DATE
July 29, 2003GROUP
1743

(37 CFR 1.98(b))

(Use several sheets if necessary)

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		PATENT NUMBER							ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	A.A	3	7	4	5	0	9	1	7/1973	McCormick	195	139	
	A.B	4	0	0	4	1	5	0	1/1977	Natelson	250	328	
	A.C	4	0	7	6	5	5	0	2/28/78	Thurn et al.	106	288	5/26/76
	A.D	4	1	5	4	7	9	5	5/1979	Thorne	422	99	
	A.E	4	2	5	1	1	5	9	2/1981	White	356	246	
	A.F	4	2	7	6	2	5	9	6/1981	Eibl et al.	422	71	
	A.G	4	2	8	4	5	4	2	8/18/81	Boyce et al.	260	27	4/7/80
	A.H	4	3	0	2	5	3	4	11/1981	Halmann et al.	435	6	
	A.I	4	3	8	5	1	1	5	5/1983	de Zabala et al.	435	33	
	A.J	4	4	2	4	0	6	7	1/1984	Tarassenko et al.	55	16	
	A.K	4	4	3	1	3	0	7	2/1984	Suovanemi	356	246	

FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS

		DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUBCLASS	TRANSLATION (YES/NO)
	A.L	0571661 A1	12/1993	EP			
	A.M	0723812 A1	7/1996	EP			
	A.N	WO 98/42442	10/1998	PCT			
	A.O						
	A.P						
	A.Q						

OTHER DOCUMENTS (Including Author, Title, Date, Place of Publication)

	A.R	Nalge Nunc International, <u>Evolving Excellence for In Situ Culture & Analysis</u> , Brochure, undated
	A.S	Nalge Nunc International, <u>Introducing Lab-Tek II The Next Generation</u> , Brochure, undated
	A.T	Nalge Nunc International, <u>Lab-Tek II Chambered Coverglass Gear Up for High-Power Inverted Methods...</u> , Brochure, undated

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EXAMINER: Initial if citation considered, whether or not in conformance. Draw line through citation only if not in conformance and not considered. Include a copy of this form with next communication to applicant.

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EXAMINER INITIAL		PATENT NUMBER							ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	B.A	4	4	6	8	3	7	1	8/1984	Chen et al.	422	102	
	B.B	4	4	9	3	8	1	5	1/1985	Fernwood et al.	422	101	
	B.C	4	5	4	5	9	5	8	10/1985	Dopatka	422	102	
	B.D	4	6	5	2	5	5	3	3/1987	Hagmann et al.	514	26	
	B.E	4	7	2	0	9	3	5	1/1988	Rogers et al.	47	56	
	B.F	4	7	3	5	7	7	8	4/1988	Maruyama et al.	422	102	
	B.G	4	7	4	1	6	1	9	5/1988	Humphries et al.	356	246	
	B.H	4	7	7	0	8	5	6	9/1988	Uthemann et al.	422	104	
	B.I	4	8	2	8	3	8	6	5/1989	Matkovich et al.	356	246	
	B.J	4	8	7	1	5	9	0	10/3/89	Merz et al.	427	387	11/6/87
	B.K	4	9	4	8	4	4	2	8/1990	Manns	156	73.1	

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	B.L						
	B.M						
	B.N						
	B.O						
	B.P						
	B.Q						

OTHER DOCUMENTS (Including Author, Title, Date, Place of Publication)

	B.R	Nalge Nunc International, <u>Nunc™ Products Laboratory Products for Cell Culture, Molecular Biology, Cyropreservation and Immunology</u> , Catalog, 1998-1999
	B.S	U.S. Patent Application Publication Number US 2003/0031829; Applicant: Tanner et al.; Published: 2/13/03
	B.T	

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EXAMINER INITIAL		PATENT NUMBER							ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	C.A	4	9	5	6	1	5	0	9/1990	Henry	422	102	
	C.B	4	9	7	3	7	4	2	11/1990	Ohsaka et al.	560	184	
	C.C	5	0	4	3	5	8	1	8/1991	Joss	250	328	
	C.D	5	0	4	7	2	1	5	9/1991	Manns	422	101	
	C.E	5	0	8	2	6	2	8	1/1992	Andreotti et al.	422	82.08	
	C.F	5	3	0	2	5	1	5	4/12/94	Goodwin, Jr.	435	29	8/20/92
	C.G	5	3	1	9	4	3	6	6/1994	Manns et al.	356	246	
	C.H	5	4	8	7	8	7	2	1/1996	Hafeman et al.	422	102	
	C.I	5	5	0	8	1	9	7	4/1996	Hansen et al.	435	285.1	
	C.J	5	5	4	0	9	7	8	7/1996	Schrenk	428	212	
	C.K	5	5	7	1	7	2	1	11/1996	Turner	435	305.1	

FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS

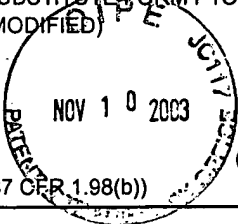
		DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUBCLASS	TRANSLATION (YES/NO)
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	C.M						
	C.N						
	C.O						
	C.P						
	C.Q						

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	C.R	
	C.S	
	C.T	

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SUBSTITUTE FORM PTO-1449 (MODIFIED)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. NAC/96DV		SERIAL NO. 10/629,053	
<div style="display: flex; justify-content: space-between;"> <div style="text-align: left;">  <p>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</p> <p>(Use several sheets if necessary)</p> </div> <div style="text-align: right;"> <p>APPLICANT Abdul Wahid Khan et al.</p> </div> </div>				FILING DATE July 29, 2003		GROUP 1743	
				U.S. PATENT DOCUMENTS			

EXAMINER INITIAL		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	D.A	5 5 8 0 5 2 8	12/1996	Demers	422	100	
	D.B	5 7 3 6 1 0 6	4/1998	Ishiguro et al.	422	131	
	D.C	5 8 5 8 3 0 9	1/1999	Mathus et al.	422	102	
	D.D	5 8 5 8 7 7 0	1/12/99	Perlman	435	305.3	9/30/97
	D.E	6 1 7 1 7 8 0	1/9/01	Pham et al.	435	4	2/24/98
	D.F	6 4 5 8 2 7 5	10/1/02	Shukla et al.	210	321.6	6/5/00
	D.G						
	D.H						
	D.I						
	D.J						
	D.K						

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		DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUBCLASS	TRANSLATION (YES/NO)
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